

# SPECIFICATION

VER. 1.3

작성	검토	팀장	App.	Marketing	Q A	Approval

# ADSemiconductor®

" Free from Common Mode Noise "

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### ■ Revision History

Rev.	Description of change	Date	Originator
1.0	First creation	13. 10. 10.	KD PARK
1.1	Revise the unit in the POD	13. 12. 06.	KD PARK
1.2	Revise the Latch-up Level Correct the sentence : "Battery Supply voltage" -> "Maximum supply voltage"	14. 05. 21.	KD PARK
1.3	Revise the operating voltage	14. 08. 11.	HS KWAK

### Content

■	Revision History .....	2
1	Features.....	4
	1.1 General Features .....	4
	1.2 Applications .....	4
2	Block Diagram.....	5
3	Pin Configuration .....	6
4	Pin Description .....	7
	4.1 Pin Map (24SSOP package) .....	8
5	Absolute Maximum Rating .....	9
6	ESD & Latch-up Characteristics .....	9
	6.1 ESD Characteristics .....	9
	6.2 Latch-up Characteristics .....	9
7	Electrical Characteristics .....	10
8	ANMG08 Implementation.....	11
	8.1 Typical current consumption .....	11
	8.2 CS implementation .....	11
	8.3 LED drive implementation .....	12
	8.4 Parallel output.....	12
	8.5 INT (Interrupt output) Implementation .....	12
	8.6 SCL, SDA implementation.....	13
9	I <sup>2</sup> C Interface.....	14
	9.1 I <sup>2</sup> C Enable / Disable.....	14
	9.2 Start & stop condition.....	14
	9.3 Data validity.....	14
	9.4 Byte format .....	14
	9.5 Acknowledge .....	14
	9.6 First byte .....	15
	9.7 Transferring data.....	16
	9.8 I <sup>2</sup> C write and read operations in normal mode .....	17
	9.9 I <sup>2</sup> C timing diagram .....	17
10	ANMG08 control register list.....	18
	10.1 I <sup>2</sup> C Register Map .....	18
	10.2 Details.....	19
11	Recommended Circuit Diagram .....	26
	11.1 ANMG08 (24 SSOP).....	26
12	MECHANICAL DRAWING .....	28
	12.1 Mechanical Drawing of ANMG08 (24 SSOP).....	28
13	MARKING DESCRIPTION .....	29
	13.1 Marking Description of ANMG08 (24 SSOP) .....	29
	NOTES: .....	30

### 1 Features

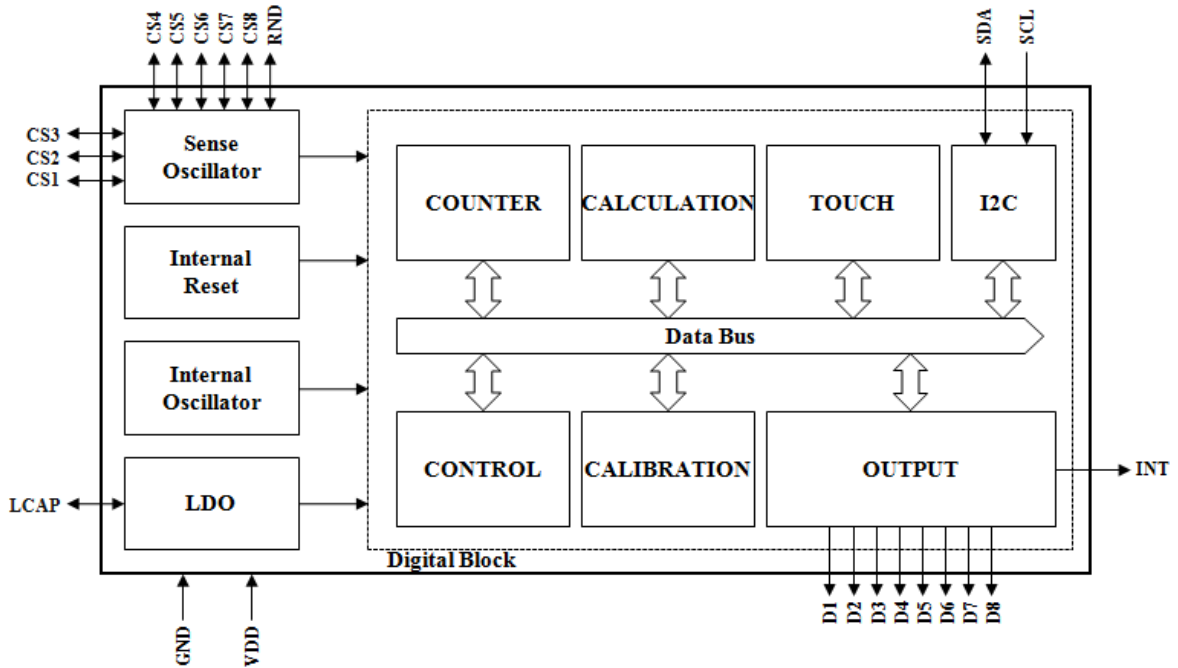
#### 1.1 General Features

- 8-Channel capacitive sensor with auto sensitivity calibration
- Available LED PWM drive up to 8
- Multi interface - I2C serial interface / Parallel outputs
- Selectable output operation mode (Single output / Multi output)
- Adjustable 256 steps sensitivity
- Almost no external component needed
- Low current consumption
- Embedded common and normal noise elimination circuit
- RoHS compliant 24SSOP packages
- Moisture sensitivity level 3 (MSL3)

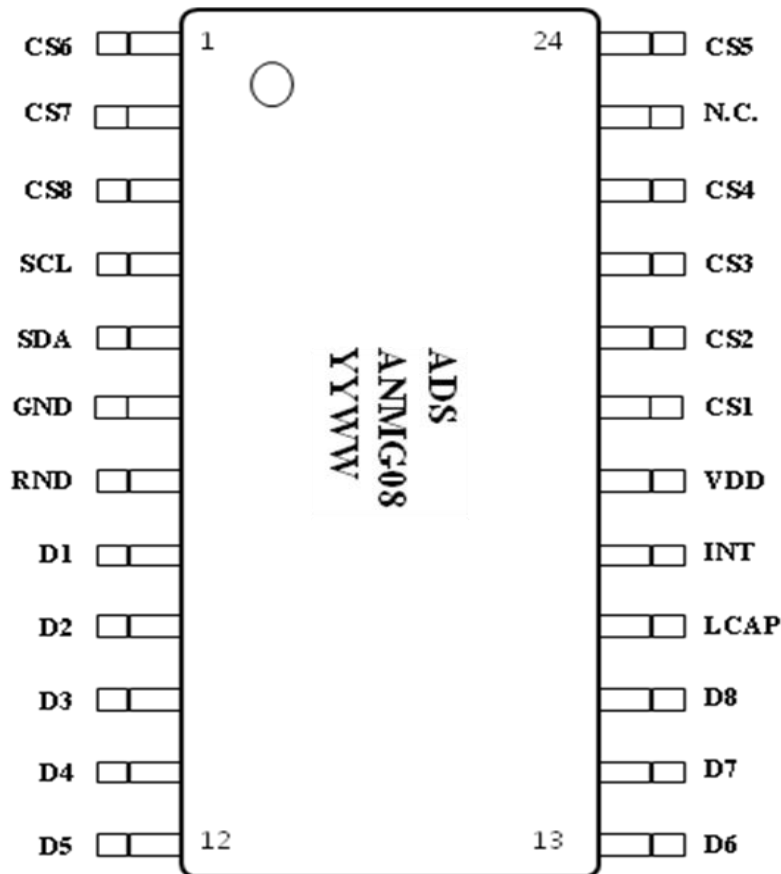
#### 1.2 Applications

- Home appliances (TV, Monitor keypads)
- Mobile applications (PMP, MP3, Car navigation)
- Membrane switch replacement
- Sealed control panels, keypads
- Touch screen replacement application Home application

### 2 Block Diagram



### 3 Pin Configuration



[24-SSOP]

### 4 Pin Description

#### **VDD, GND**

Supply voltage and ground pin.

#### **R.N.D**

Radio frequency Noise Detection pin. Normally, R.N.D pin does not connect to anywhere.

But, in radio frequency noise environment, this pin must form a pattern line on PCB.

#### **CS1 ~ CS8**

Capacitive sensor input pins.

#### **LCAP**

Internal LDO output port.

#### **D1 ~ D8**

Parallel output ports of CS1~CS8 respectively / LED PWM drive output ports. The structure of these parallel output ports is open drain NMOS for active low output level operation.

#### **SCL, SDA**

SCL is I<sup>2</sup>C clock input pin and SDA is I<sup>2</sup>C data input-output pin. These ports have internal pull-up resistor.

In case of not use, this pin must be not connected to any circuitry.

#### **INT**

Touch sensing interrupt output pin. This port has internal pull-up resistor.

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 4.1 Pin Map (24SSOP package)

Pin Number	Name	I/O	Description	Protection
1	CS6	Analog Input	Capacitive sensor input 6	VDD/GND
2	CS7	Analog Input	Capacitive sensor input 7	VDD/GND
3	CS8	Analog Input	Capacitive sensor input 8	VDD/GND
4	SCL	Digital Input	I <sup>2</sup> C clock input	VDD/GND
5	SDA	Digital Input / Output	I <sup>2</sup> C data input-output Open drain NMOS structure	VDD/GND
6	GND	Ground	Supply ground	VDD
7	R.N.D	Analog Input	Radio frequency Noise Detection pin	VDD/GND
8	D1	Digital Output	Parallel output of CS1 LED PWM drive output1 Open drain NMOS structure	VDD/GND
9	D2	Digital Output	Parallel output of CS2 LED PWM drive output2 Open drain NMOS structure	VDD/GND
10	D3	Digital Output	Parallel output of CS3 LED PWM drive output3 Open drain NMOS structure	VDD/GND
11	D4	Digital Output	Parallel output of CS4 LED PWM drive output4 Open drain NMOS structure	VDD/GND
12	D5	Digital Output	Parallel output of CS5 LED PWM drive output5 Open drain NMOS structure	VDD/GND
13	D6	Digital Output	Parallel output of CS6 LED PWM drive output6 Open drain NMOS structure	VDD/GND
14	D7	Digital Output	Parallel output of CS7 LED PWM drive output7 Open drain NMOS structure	VDD/GND
15	D8	Digital Output	Parallel output of CS8 LED PWM drive output8 Open drain NMOS structure	VDD/GND
16	LCAP	Analog Output	Internal LDO Output	VDD/GND
17	INT	Digital Output	Touch sensing interrupt output Open drain NMOS structure	VDD/GND
18	VDD	Power	Power (3.0V~5.5V)	GND
19	CS1	Analog Input	Capacitive sensor input 1	VDD/GND
20	CS2	Analog Input	Capacitive sensor input 2	VDD/GND
21	CS3	Analog Input	Capacitive sensor input 3	VDD/GND
22	CS4	Analog Input	Capacitive sensor input 4	VDD/GND
23	N.C.	-	-	-
24	CS5	Analog Input	Capacitive sensor input 5	VDD/GND



### 5 Absolute Maximum Rating

Maximum supply voltage	5.5V
Maximum voltage on any pin	VDD+0.3
Maximum current on any PAD	100mA
Power Dissipation	800mW
Storage Temperature	-50 ~ 150 °C
Operating Temperature	-20 ~ 75 °C
Junction Temperature	150 °C

Note : Unless any other command is noted, all above are operated in normal temperature.

### 6 ESD & Latch-up Characteristics

#### 6.1 ESD Characteristics

Mode	Polarity	Max	Reference
H.B.M	Pos / Neg	8000V	VDD
		8000V	VSS
		8000V	P to P
M.M	Pos / Neg	550V	VDD
		550V	VSS
		400V	P to P
C.D.M	-	800V	Field Induced Charge

#### 6.2 Latch-up Characteristics

Mode	Polarity	Max	Reference
I Test	Positive	200mA	JESD78D : 2011
	Negative	200mA	
V supply over 5.0V	Positive	8.25V	

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 7 Electrical Characteristics

▪  $V_{DD}=3.3V$ , Typical system frequency (Unless otherwise noted),  $T_A = 25^\circ C$

Characteristics	Symbol	Test Condition	Min	Typ	Max	Units
<b>Power supply requirement and current consumption</b>						
Operating voltage	$V_{DD}$		3.0		5.5	V
Current consumption	$I_{DD}$	$V_{DD}= 3.3V$ , Standby state	-	0.50	-	mA
<b>Reset and input level</b>						
Internal reset voltage	$V_{DD\_RST}$	$T_A = 25^\circ C$	-	2.1	-	V
Input high level	$V_{IH}$	$ I_{IH}  \leq +5\mu A$	$V_{DD} * 0.6$		$V_{DD} + 0.3$	V
Input low level	$V_{IL}$	$ I_{IL}  \leq +5\mu A$	-0.3		$V_{DD} * 0.3$	V
Self calibration time after system reset	$T_{CAL}$	Slow calibration speed	-	100	-	msec
		Normal calibration speed	-	80	-	
		Fast calibration speed	-	60	-	
Internal Pull Up resistor of SDA, SCL, INT	$R_{P/U}$		-	30	-	k $\Omega$
<b>Touch sensing performance</b>						
Minimum detectable capacitance difference	$\Delta C_{MIN}$		0.1	-	-	pF
Sense input capacitance range <sup>1</sup>	$C_S$		-	-	50	pF
Output impedance (open drain)	$Z_O$	$\Delta C > \Delta C_{MIN}$	-	12	-	$\Omega$
		$\Delta C < \Delta C_{MIN}$	-	30M	-	
<b>System performance</b>						
Max. output current (LED drive current)	$I_{OUT}$	Per unit drive output port	-	-	8.0	mA
LED PWM control <sup>2</sup>	$N_{PWM}$		-	16	-	step
Sensitivity control <sup>3</sup>			-	256	-	step
Max. I <sup>2</sup> C SCL clock speed	$f_{SCL\_MAX}$	Maximum internal I <sup>2</sup> C clock	-	-	2	MHz
Touch expired time	$T_{EX}$	Normal calibration speed	-	30	-	sec

<sup>1</sup> The sensitivity can be decreased with higher parallel capacitance of CS pin including parasitic capacitance made by neighbor GND or other pattern. The series resistor(under 1k $\Omega$ ) of CS can be used in noisy condition to avoid mal-function from external surge and ESD.

<sup>2</sup> Refer to the chapter 10.2.12. LED luminance control register

<sup>3</sup> Refer to the chapter 10.2.8. Sensitivity register

### 8 ANMG08 Implementation

#### 8.1 Typical current consumption

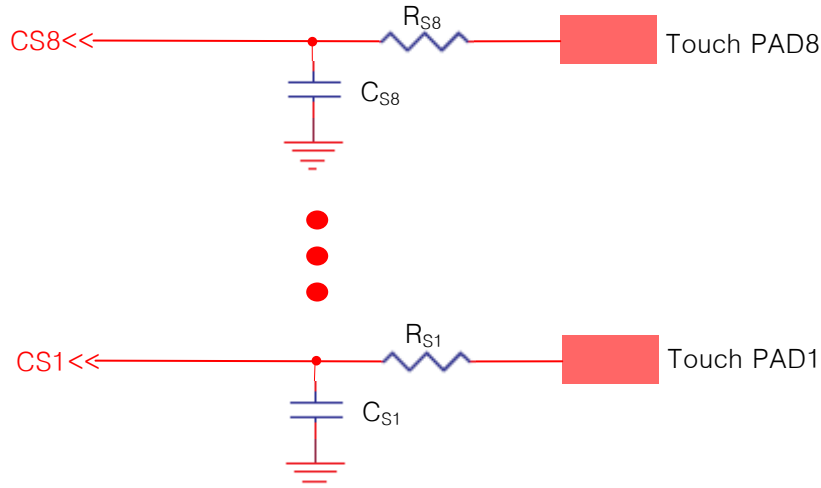
ANMG08 uses internal bias circuit, so internal clock frequency and current consumption is fixed and no external bias circuit is needed. Internal clock frequency and calibration speed can be changed by I<sup>2</sup>C register setting<sup>4</sup>. Faster calibration speed needs more current consumption than normal or slower calibration speed. Slow calibration speed isn't recommended if it has not problem of current consumption.

Internal bias circuit can make the circuit design simple and reduce external components.

#### 8.2 CS implementation

ANMG08 has 256 step selections of sensitivity and internal surge protection resistor. Sensitivity of each sensing channel (CS) can be independently controlled on others. External components of CS pin such as series resistor or parallel capacitor isn't necessary. The parallel parasitic capacitance of CS pins caused by touch line, touch pad and neighbor GND or other pattern may affect sensitivity. The sensitivity will be decreased when bigger parallel parasitic capacitance of CS pin is added.

Parallel capacitor (C<sub>S1~S8</sub>) of CS pin is useful in case of detail sensitivity mediation is required such as for complementation sensitivity difference between channels. Same as above parallel parasitic capacitance, sensitivity will be decreased when a big value of parallel capacitor (C<sub>S1~S8</sub>) is used. Under 50pF capacitor can be used as sensitivity meditation capacitor and a few pF is usually used. The R<sub>S</sub>, serial connection resistor of CS pins, may be used to avoid mal-function from external surge and ESD. (It might be optional.) From 200Ω to 1kΩ is recommended for R<sub>S</sub>. Refer to below CS pins application figure.



The ANMG08 has eight independent touch sensor input from CS1 to CS8. The internal touch decision process of each channel is separated from others. Therefore eight channel touch key board application can be designed by using only one ANMG08 without coupling problems.

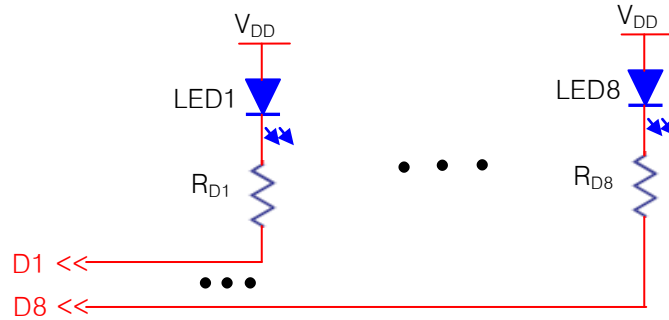
The size and shape of PAD might have influence on the sensitivity. The sensitivity will be optimal when the size of PAD is approximately an half of the first knuckle (it's about 10 mm x 7 mm). The connection line of CS to touch PAD is recommended to be routed as short as possible to prevent from abnormal touch detect caused by connection line. The unused CS pin should not be connected with the ground.

<sup>4</sup> Refer to 10.2.4. Clock control register.

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

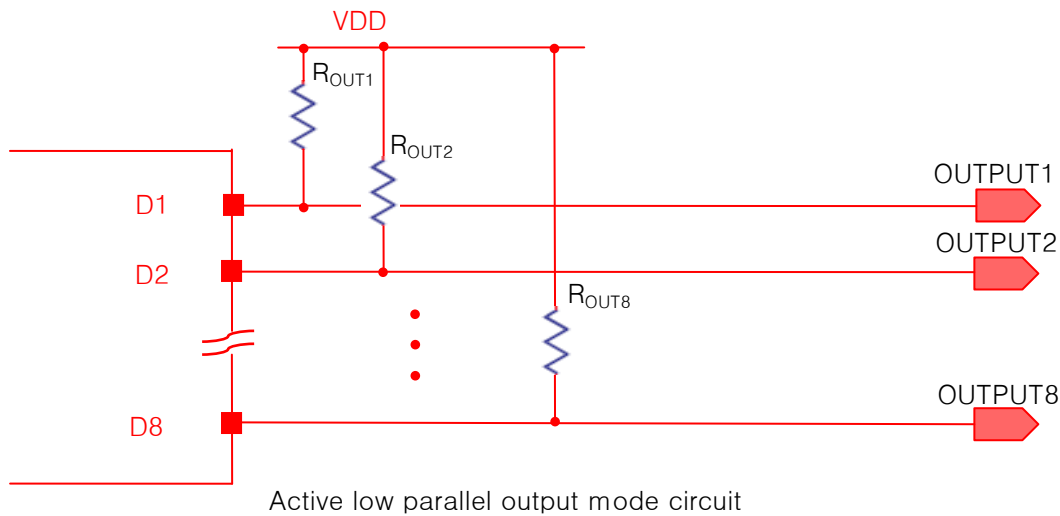
### 8.3 LED drive implementation

ANMG08 has a function to control the LED using D1~D8 ports. For using D1~D8 as LED driver ports, LEDs and resistors must be equipped as below figure, and write the 'port\_mode' register<sup>5</sup> as '1'. D1 ~ D8 ports can drive LEDs by 'PWM\_ctrlx' register<sup>6</sup> control. ANMG08 can drive up to 8 LED as below method.



### 8.4 Parallel output

ANMG08 acts as active low parallel output mode. Parallel output ports (D1~D8) have an open drain NMOS structure. For this reason, the parallel output mode of ANMG08 needs  $R_{OUT}$  as below figures. The maximum output drive current is 8mA, so over a few kΩ must be used as  $R_{OUT}$ . Normally 10kΩ is used as  $R_{OUT}$ .

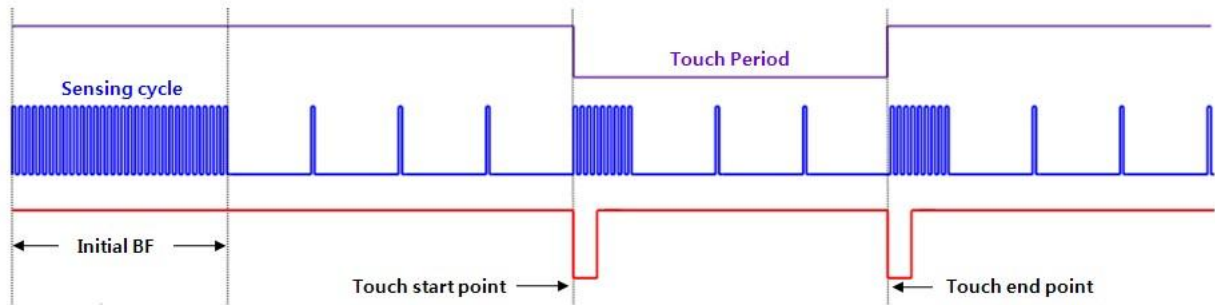


### 8.5 INT (Interrupt output) Implementation

An INT pin is for the touch sensing interrupt output. The interrupt pulse is generated only during short period of every each channel touch start point and touch end point. Interrupt pulse has logical low level. INT has NMOS open drain structure and internal pull-up resistor of which value is 30kΩ typical.

<sup>5</sup> Refer to the chapter 10.2.12. Port mode control register

<sup>6</sup> Refer to the chapter 10.2.11. LED luminance control register



### 8.6 SCL, SDA implementation

SCL is I<sup>2</sup>C clock input and SDA is I<sup>2</sup>C data input-output. These ports have internal pull-up resistor. SCL has Schmitt trigger input structure to prevent clock signal from being broken. Maximum supported I<sup>2</sup>C clock frequency is 2MHz. SDA has NMOS open drain structure and internal pull-up resistor of which value is 30k $\Omega$  typical. So, according to communication speed a few k $\Omega$  resistor must be used as pull-up resistor for proper data pulse rising time. For more details refer to 'Chapter 9. I<sup>2</sup>C Interface'.

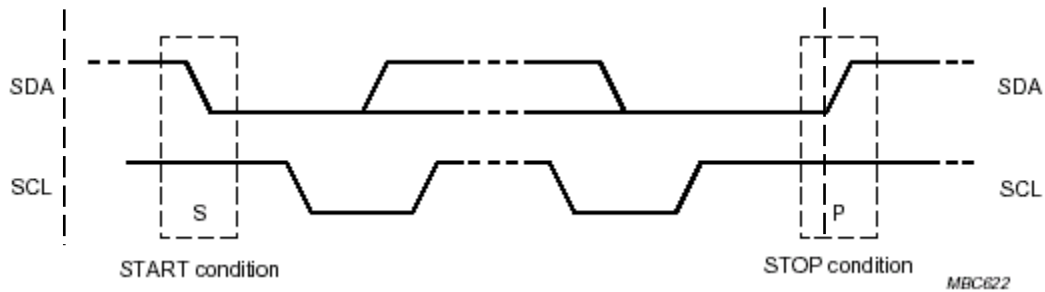
### 9 I<sup>2</sup>C Interface

#### 9.1 I<sup>2</sup>C Enable / Disable

If the SDA or SCL signal goes low, I<sup>2</sup>C control block is enabled automatically. And if the SDA and SCL signal maintain high during about 2 us, I<sup>2</sup>C control block is disabled automatically also.

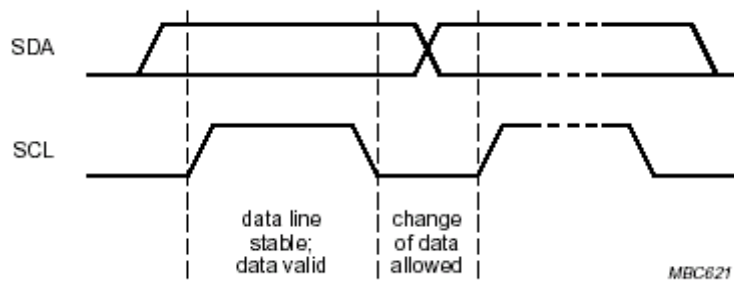
#### 9.2 Start & stop condition

- ◀ Start Condition (S)
- ◀ Stop Condition (P)
- ◀ Repeated Start (Sr)



#### 9.3 Data validity

The SDA should be stable when the SCL is high and the SDA can be changed when the SCL is low.



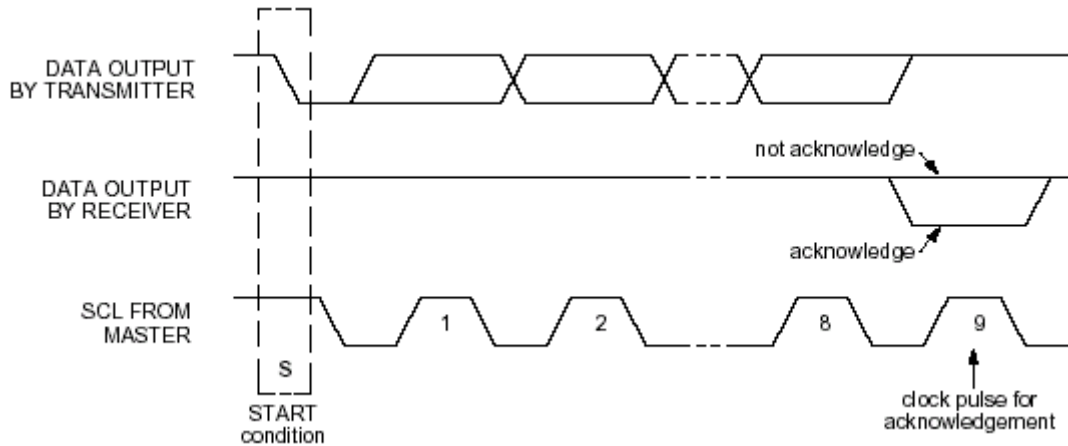
#### 9.4 Byte format

The byte structure is composed with 8Bit data and an acknowledge signal.

#### 9.5 Acknowledge

It is a check bit whether the receiver gets the data from the transmitter without error or not. The receiver will write '0' when it received the data successfully and '1' if not.

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)



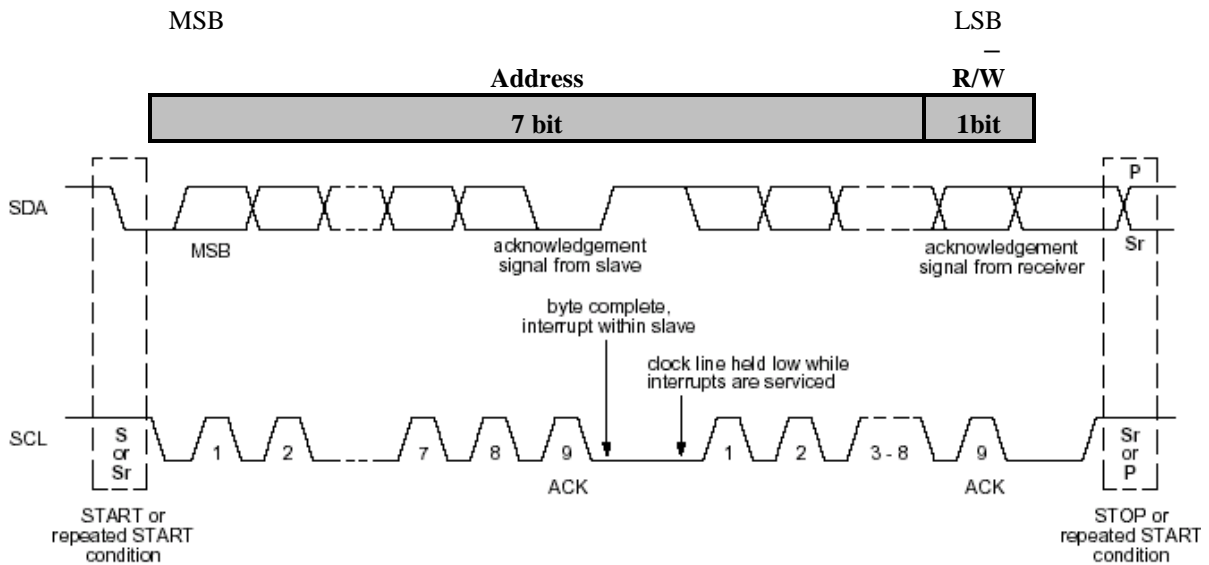
### 9.6 First byte

#### 9.6.1 Slave address

It is the first byte from the start condition. It is used to access the slave device. The initial chip address of ANMG08 is '48' hexadecimal number.

#### 9.6.2 R/W

The direction of data is decided by the bit and it follows the address data.



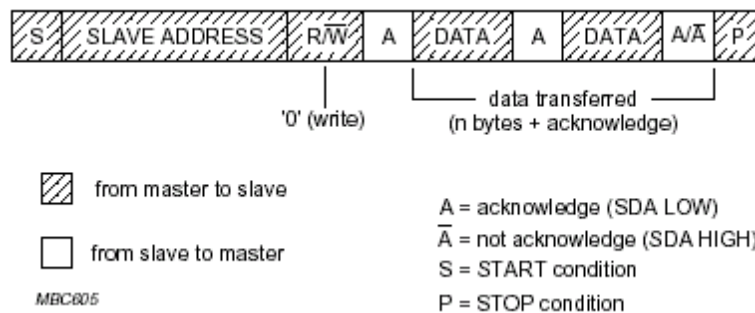
## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 9.7 Transferring data

#### 9.7.1 Write operation

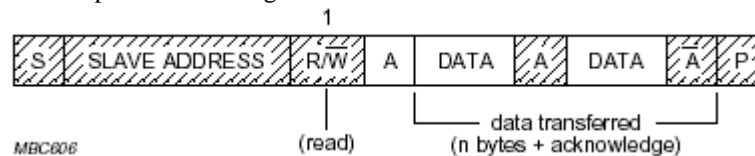
The byte sequence is as follows:

1. The first byte gives the device address plus the direction bit (R/W = 0).
2. The second byte contains the internal address of the first register to be accessed.
3. The next byte is written in the internal register. Following bytes are written in successive internal registers.
4. The transfer lasts until stop conditions are encountered.
5. The ANMG08 acknowledges every byte transfer.

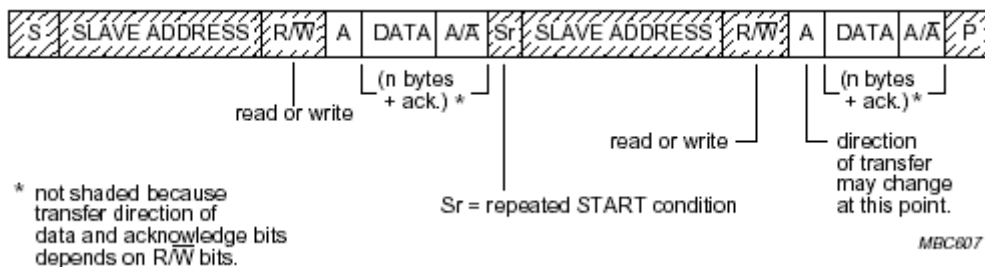


#### 9.7.2 Read operation

The address of the first register to read is programmed in a write operation without data, and terminated by the stop condition. Then, another start is followed by the device address and R/W= 1. All following bytes are now data to be read at successive positions starting from the initial address.



#### 9.7.3 Read/Write Operation





## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 9.8 I<sup>2</sup>C write and read operations in normal mode

The following figure represents the I<sup>2</sup>C normal mode write and read registers.

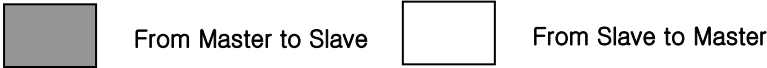
☞ Write register 0x00 to 0x01 with data AA and BB

Start	Device Address 0x48	ACK	Register Address 0x00	ACK	Data AA	ACK	Data BB	ACK	Stop
-------	---------------------	-----	-----------------------	-----	---------	-----	---------	-----	------

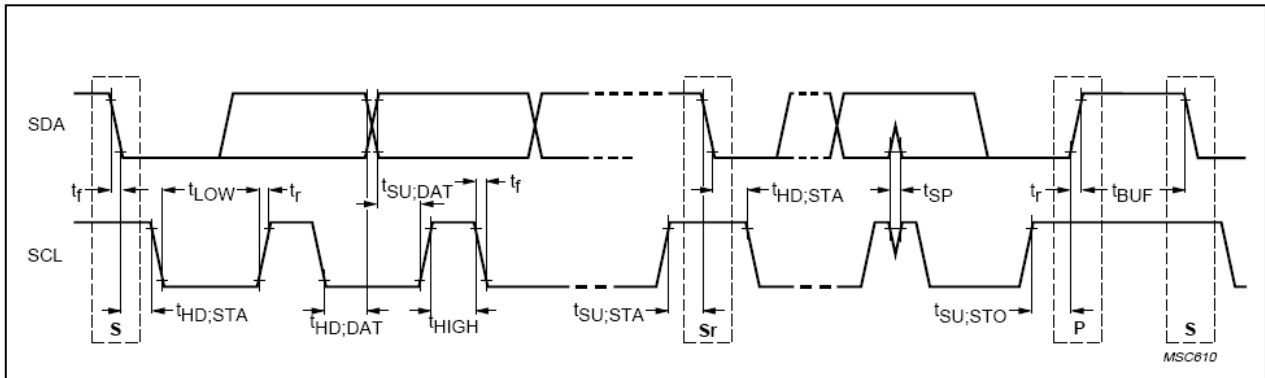
Read register 0x00 and 0x01

Start	Device Address 0x48	ACK	Register Address 0x00	ACK	Stop
-------	---------------------	-----	-----------------------	-----	------

Start	Device Address 0x49	ACK	Data Read AA	ACK	Data Read BB	ACK	Stop
-------	---------------------	-----	--------------	-----	--------------	-----	------



### 9.9 I<sup>2</sup>C timing diagram



PARAMETER	SYMBOL	100kbps		400kbps		UNIT
		MIN.	MAX.	MIN.	MAX.	
Hold time (repeated)START condition.	tHD;STA	4.0	-	0.6	-	us
LOW period of the SCL clock	tLOW	4.7	-	1.3	-	us
HIGH period of the SCL clock	tHIGH	4.0	-	0.6	-	us
Set-up time for a repeated START condition	tSU;STA	4.7	-	0.6	-	us
Data hold time	tHD;DAT	1.0	-	-	-	us
Data set-up time	tSU;DAT	250	-	100	-	ns
Rise time of both SDA and SCL signals	tr	-	1000	20	300	ns
Fall time of both SDA and SCL signals	tf	-	300	20	300	ns
Set-up time for STOP condition	tSU;STO	4.0	-	0.6	-	us
Bus free time between a STOP and START condition	tBUF	4.7	-	1.3	-	us
Noise margin at the LOW level for each connected device	VnL	0.1VDD	-	0.1VDD	-	V
Noise margin at the HIGH level for each connected device	VnH	0.2VDD	-	0.2VDD	-	V
Input Low level				0	V <sub>DD</sub> *0.2	V
Input High level				V <sub>DD</sub> *0.8	V <sub>DD</sub>	V

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 10 ANMG08 control register list

◀ Note: The unused bits (defined as reserved) in I<sup>2</sup>C registers must be kept to zero.

#### 10.1 I<sup>2</sup>C Register Map

Name	Addr (Hex)	Reset Value (Bin)	Bit name of each bytes								
			Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	
ch_enable /soft_rst	01H	1111 1111	ch8_en	ch7_en	ch6_en	ch5_en	ch4_en	ch3_en	ch2_en	ch1_en	
i2c_id	06H	0100 1000	i2c_id								wr_bit
output	2AH	Read only	o_ch8	o_ch7	o_ch6	o_ch5	o_ch4	o_ch3	o_ch2	o_ch1	
clock_ctrl	34H	0000 0110	init_cal_opt			-	clk_sel		rb_sel		
global_ctrl1	36H	0100 1100	response_off_ctrl			response_ctrl		bf_mode	software_rst		
state_count	37H	1111 1111	1	1	1	cal_pre_scaler					
global_ctrl2	38H	1011 1100	imp_sel	sin_multi_mod e	cal_hold_time				0	clk_off	
sensitivity1	39H	0001 1100	sensitivity01								
sensitivity2	3AH	0001 1100	sensitivity02								
sensitivity3	3BH	0001 1100	sensitivity03								
sensitivity4	3CH	0001 1100	sensitivity04								
sensitivity5	3DH	0001 1100	sensitivity05								
sensitivity6	3EH	0001 1100	sensitivity06								
sensitivity7	3FH	0001 1100	sensitivity07								
sensitivity8	40H	0001 1100	sensitivity08								
cal_speed	41H	0110 0110	rnd_bf_up		rnd_bf_down		sen_bf_up		sen_bf_down		
cal_BS_spe ed	42H	0110 0110	rnd_bs_up		rnd_bs_down		sen_bs_up		sen_bs_down		
PWM_ctrl1	43H	0000 0000	pwm_d2				pwm_d1				
PWM_ctrl2	44H	0000 0000	pwm_d4				pwm_d3				
PWM_ctrl3	45H	0000 0000	pwm_d6				pwm_d5				
PWM_ctrl4	46H	0000 0000	pwm_d8				pwm_d7				
port_mode	4FH	0000 0000	pmod_d8	pmod_d7	pmod_d6	pmod_d5	pmod_d4	pmod_d3	pmod_d2	pmod_d1	
rd_ch_H1	50H	Read only	rd_ch_H1								
rd_ch_L1	51H		-	-	-	-	-	-	-	rd_ch_L1	
Percent_H	52H		touch_percent[24:17]								
Percent_M	53H		touch_percent[16:9]								
Percent_L	54H		touch_percent[8:1]								
rd_ch_H2	56H		rd_ch_H2								
rd_ch_L2	57H		-	-	-	-	-	-	-	rd_ch_L2	

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 10.2 Details

#### 10.2.1 Channel enable / reset register

Type: R/W

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
01h	ch_enable /soft_rst	ch8_en	ch7_en	ch6_en	ch5_en	ch4_en	ch3_en	ch2_en	ch1_en

#### Description

Enable, disable and reset of each channel control register.

Bit name	Reset value	Function
chx_en	1	Channel enable / disable and Channel reset (chx_en is control bit for CSx channel) <ul style="list-style-type: none"> <li>● 0 : Channel disable and sensing channel reset</li> <li>● 1 : Channel enable</li> </ul>

#### 10.2.2 I<sup>2</sup>C address of ANMG08

Type: R/W

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
06h	i2c_id	i2c_id							wr_bit

#### Description

Chip address of ANMG08 control register.

Bit name	Reset value	Function
wr_bit	0	Write/Read address selection - 0 : Write address, 1 : Read address
i2c_id	0100100	Chip address of ANMG08.

#### 10.2.3 Output data

Type: R

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
2Ah	output	o_ch8	o_ch7	o_ch6	o_ch5	o_ch4	o_ch3	o_ch2	o_ch1

#### Description

The output data register from channel 1 to channel 8.

Bit name	Reset value	Function
o_chx	Read only	o_chx is output bit for CSx channel <ul style="list-style-type: none"> <li>⚡ 0 : No touch detected</li> <li>⚡ 1 : Touch detected</li> </ul>

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 10.2.4 Clock control register

Type: R/W

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
34h	clock_ctrl	init_cal_opt			-	clk_sel		rb_sel	

#### Description

This register controls the global options of ANMG08

Bit name	Reset value	Function
rb_sel	10	ANMG08 provides three internal calibration speeds with this register. <ul style="list-style-type: none"> <li><span style="color: red;">+</span> 00, 01 : Fast</li> <li><span style="color: blue;">+</span> 10 : Normal</li> <li><span style="color: green;">+</span> 11 : Slow</li> </ul>
clk_sel	01	ANMG08 provides four internal calibration speeds with this register. <ul style="list-style-type: none"> <li><span style="color: red;">+</span> 00 : Fast</li> <li><span style="color: blue;">+</span> 01 : Normal</li> <li><span style="color: green;">+</span> 10 : Slow</li> <li><span style="color: purple;">+</span> 11 : Slowest</li> </ul>
init_cal_opt	000	To control the initial BF time. <ul style="list-style-type: none"> <li><span style="color: red;">+</span> init_cal_opt[2:0] * 5 + 5 (Seconds)</li> </ul>

### 10.2.5 Global option control register 1

Type: R/W

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
36h	global_ctrl1	response_off_ctrl			response_ctrl			bf_mode	software_rst

#### Description

This register controls the global options of ANMG08

Bit name	Reset value	Function
software_rst	0	Software reset control bit. Reset the data of all sensing channel. <ul style="list-style-type: none"> <li><span style="color: red;">+</span> 0 : No reset</li> <li><span style="color: blue;">+</span> 1 : Reset</li> </ul>
bf_mode	0	Operation mode selection <ul style="list-style-type: none"> <li><span style="color: black;">●</span> 0 : Normal mode</li> <li><span style="color: black;">●</span> 1 : BF mode</li> </ul>
response_ctrl	011	Numbers of continuous touch detections for touch decision. <ul style="list-style-type: none"> <li><span style="color: red;">+</span> response_ctrl[2:0] + 1 (Maximum time : 7)</li> </ul>
response_off_ctrl	010	Numbers of continuous touch off detections for touch off decision. <ul style="list-style-type: none"> <li><span style="color: red;">+</span> response_off_ctrl[2:0] + 1 (Maximum time : 7)</li> </ul>

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 10.2.6 State count control register

Type: R/W

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
37h	state_count	1	1	1	cal_pre_scaler				

#### Description

Register to set the pre-scaler for the calibration speed.

Bit name	Reset value	Function
cal_pre_scaler	1 1111	The pre-scaler for the calibration speed. <span style="color: red;">+</span> cal_pre_scaler[4:0] x 16ms (1-period)

### 10.2.7 Global option control register 2

Type: R/W

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
38h	global_ctrl2	imp_sel	sin_multi_mode	cal_hold_time			0	clk_off	

#### Description

This register controls the global options of ANMG08.

Bit name	Reset value	Function
clk_off	0	System clock off control bit. <span style="color: red;">+</span> 0 : Not clock off <span style="color: red;">+</span> 1 : Clock off
cal_hold_time	1111	Output expiration Time control. <span style="color: red;">+</span> cal_hold_time[3:0] x 4 ( seconds) <span style="color: red;">+</span> The output expiration time is infinite when the data of the “cal_hold_time” is “0000”.
sin_multi_mode	0	Single/Multi output operation mode selection bit. <span style="color: red;">+</span> 0 : Multi output mode <span style="color: red;">+</span> 1 : Single output mode
imp_sel	1	Impedance of the sensing wire of all channels control bit. <span style="color: red;">+</span> 0 : High impedance <span style="color: red;">+</span> 1 : Low impedance except sensing period.

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 10.2.8 Sensitivity register

Type: R/W

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
39H	sensitivity1								sensitivity01
3AH	sensitivity2								sensitivity02
3BH	sensitivity3								sensitivity03
3CH	sensitivity4								sensitivity04
3DH	sensitivity5								sensitivity05
3EH	sensitivity6								sensitivity06
3FH	sensitivity7								sensitivity07
40H	sensitivity8								sensitivity08

#### Description

This register controls the global options of ANMG08.

Bit name	Reset value	Function
sensitivity0x	0001 1100	Sensitivities of each channel. Sensitivity of CSx channel: {(sensitivity0x[7:0] x 0.025)} (%).

### 10.2.9 Calibration speed control register

Type: R/W

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
41H	cal_speed	rnd_bf_up		rnd_bf_down		sen_bf_up		sen_bf_down	

#### Description

Calibration speed can be controlled by this 'cal\_speed' register at BF mode.

Bit name	Reset value	Function
sen_bf_down	10	Sense channel down calibration speed at BF mode control bits. <ul style="list-style-type: none"> <li>⚡ 00 : Fastest</li> <li>⚡ 01 : Fast</li> <li>⚡ 10 : Normal</li> <li>⚡ 11 : Slow</li> </ul>
sen_bf_up	01	Sense channel up calibration speed at BF mode control bits. <ul style="list-style-type: none"> <li>⚡ 00 : Fastest</li> <li>⚡ 01 : Fast</li> <li>⚡ 10 : Normal</li> <li>⚡ 11 : Slow</li> </ul>
rnd_bf_down	10	RND channel down calibration speed at BF mode control bits. <ul style="list-style-type: none"> <li>⚡ 00 : Fastest</li> <li>⚡ 01 : Fast</li> <li>⚡ 10 : Normal</li> <li>⚡ 11 : Slow</li> </ul>
rnd_bf_up	01	RND channel up calibration speed at BF mode control bits. <ul style="list-style-type: none"> <li>⚡ 00 : Fastest</li> <li>⚡ 01 : Fast</li> <li>⚡ 10 : Normal</li> <li>⚡ 11 : Slow</li> </ul>

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 10.2.10 Calibration speed control register at BS mode

Type: R/W

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
42H	cal_BS_speed	rnd_bs_up		rnd_bs_down		sen_bs_up		sen_bs_down	

#### Description

Calibration speed can be controlled by this 'cal\_BS\_speed' register at BS mode.

Bit name	Reset value	Function
sen_bs_down	10	Sense channel down calibration speed at BS mode control bits. 🚦 00 : Fastest 🚦 01 : Fast 🚦 10 : Normal 🚦 11 : Slow
sen_bs_up	01	Sense channel up calibration speed at BS mode control bits. 🚦 00 : Fastest 🚦 01 : Fast 🚦 10 : Normal 🚦 11 : Slow
rnd_bs_down	10	RND channel down calibration speed at BS mode control bits. 🚦 00 : Fastest 🚦 01 : Fast 🚦 10 : Normal 🚦 11 : Slow
rnd_bs_up	01	RND channel up calibration speed at BS mode control bits. 🚦 00 : Fastest 🚦 01 : Fast 🚦 10 : Normal 🚦 11 : Slow

### 10.2.11 LED luminance control register

Type: R/W

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
43h	PWM_ctrl1	pwm_d2				pwm_d1			
44h	PWM_ctrl2	pwm_d4				pwm_d3			
45h	PWM_ctrl3	pwm_d6				pwm_d5			
46h	PWM_ctrl4	pwm_d8				pwm_d7			

#### Description

LED luminance can be controlled by "PWM\_ctrlx" register.

Bit name	Reset value	Function
pwm_dx	0000	The LED PWM control bits of Dx port. 🚦 0000 : The minimum low duty 🚦 1111 : The maximum low duty

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 10.2.12 Port mode control register

Type: R/W

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
4Fh	port_mode	pmod_d 8	pmod_d 7	pmod_d 6	pmod_d 5	pmod_d 4	pmod_d 3	pmod_d 2	pmod_d 1

#### Description

This register controls the mode of output port.

Bit name	Reset value	Function
pmod_dx	0	Select the output port operation mode of each channel. 0 : Parallel output mode 1 : LED drive mode



## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 10.2.13 Sense, reference count read register

Type: R

Address	Register Name	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
50h	rd_ch_H1	rd_ch_H1							
51h	rd_ch_L1	-	-	-	-	-	-	-	rd_ch_L1
52h	Percent_H	touch_percent[25:18]							
53h	Percent_M	touch_percent[17:10]							
54h	Percent_L	touch_percent[9:2]							
56h	rd_ch_H2	rd_ch_H2							
57h	rd_ch_L2	-	-	-	-	-	-	-	rd_ch_L2

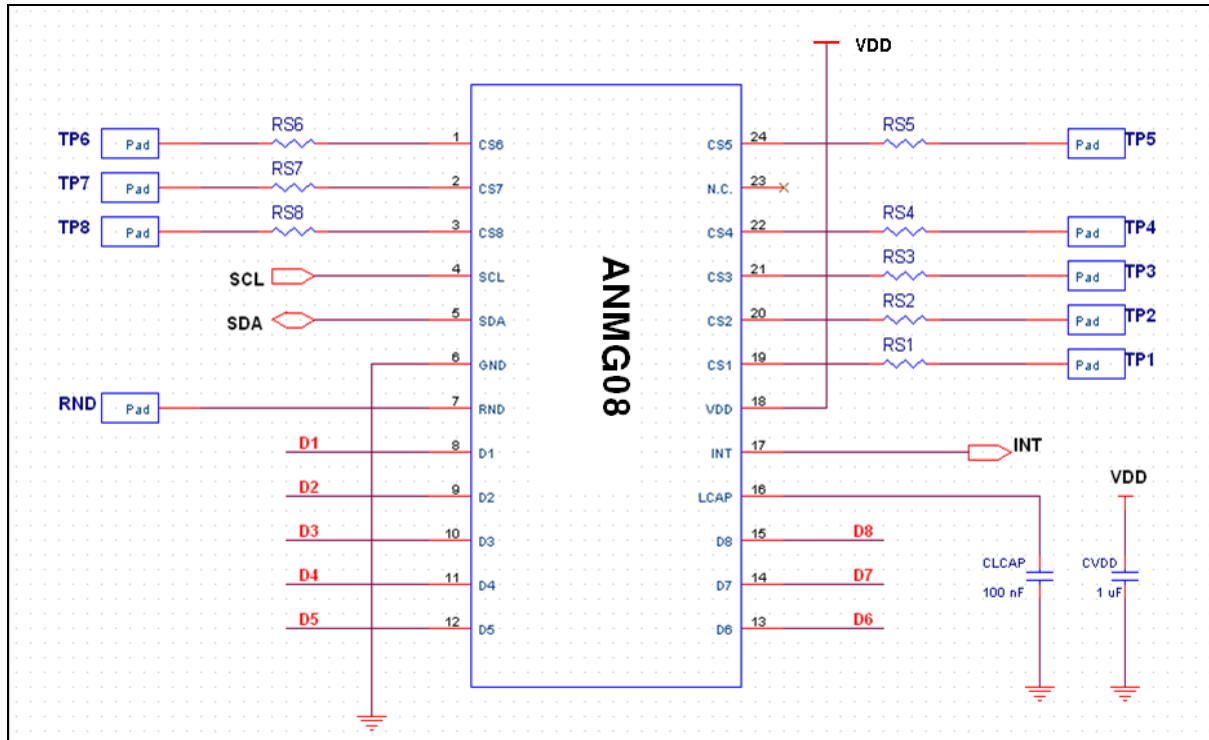
#### Description

ANMG08 provides the special function to read sense count of each channels or reference count.

Bit name	Reset value	Function
rd_ch_H1	Read only	Read channel indication register. 00000001 : - 00000010 : R.N.D channel 00000100 : CS1 channel 00001000 : CS2 channel 00010000 : CS3 channel 00100000 : CS4 channel 01000000 : CS5 channel 10000000 : CS6 channel
rd_ch_L1	Read only	Read channel indication register. 01 : CS7 channel 10 : CS8 channel
touch_percent[24:17]	Read only	The percent data of RND channel and sense channels. [25:18] bits of the touch percent data.
touch_percent[16:9]	Read only	The percent data of RND channel and sense channels. [17:10] bits of the touch percent data.
touch_percent[8:1]	Read only	The percent data of RND channel and sense channels. [9:2] bits of the touch percent data.
rd_ch_H2	Read only	Read channel indication register. 00000001 : - 00000010 : R.N.D channel 00000100 : CS1 channel 00001000 : CS2 channel 00010000 : CS3 channel 00100000 : CS4 channel 01000000 : CS5 channel 10000000 : CS6 channel
rd_ch_L2	Read only	Read channel indication register. 01 : CS7 channel 10 : CS8 channel

### 11 Recommended Circuit Diagram

#### 11.1 ANMG08 (24 SSOP)



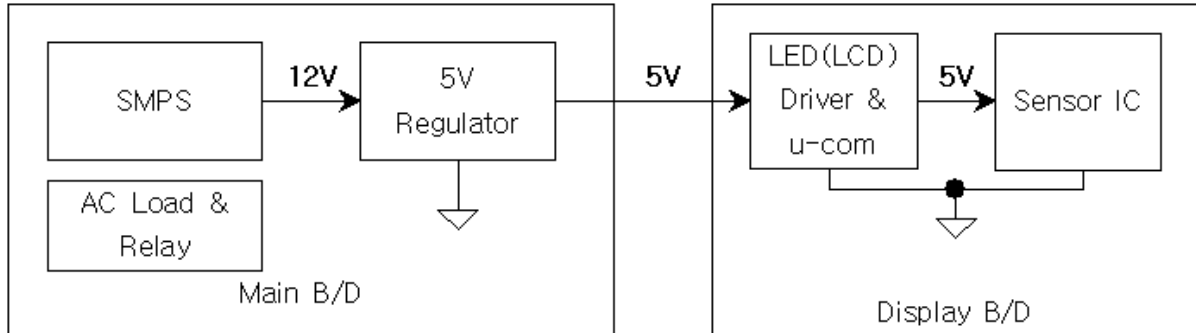
ANMG08 (24 SSOP) Application Example Circuit

- ✓ ANMG08 is reset by internal reset circuit. VDD voltage rising time should be shorter than 100msec for proper operation.
- ✓ Normally, R.N.D pin dose not connection to anywhere. But, in radio frequency noise environment, R.N.D pin must form a pattern line on PCB.
- ✓ The VDD periodic voltage ripple over 50mV and the ripple frequency is lower than 10 kHz can cause wrong sensitivity calibration. To prevent above problem, power (VDD, GND) line of touch circuit should be separated from other circuit. Especially LED driver power line or digital switching circuit power line certainly should be treated to be separated from touch circuit.
- ✓ The CS patterns also should be routed as short as possible and the width of line might be about 0.25mm.
- ✓ Parallel capacitor of CS pin could be useful in case detail sensitivity mediation is required such as for complementation sensitivity difference between channels.
- ✓ Serial connection resistor of CS pins may be used to avoid mal-function from external surge and ESD and the closer to IC(ANMG08), the stronger immunity against mal-function and ESD is.
- ✓ The CVDD capacitor that is between VDD and GND is an obligation.
- ✓ CVDD and CLCAP capacitors should be located as close as possible from ANMG08.
- ✓ The CS pattern routing should be formed by bottom metal (opposite metal of touch PAD).
- ✓ The empty space of PCB must be filled with GND pattern to strengthen GND pattern and to prevent external noise from interfere with sensing frequency.

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

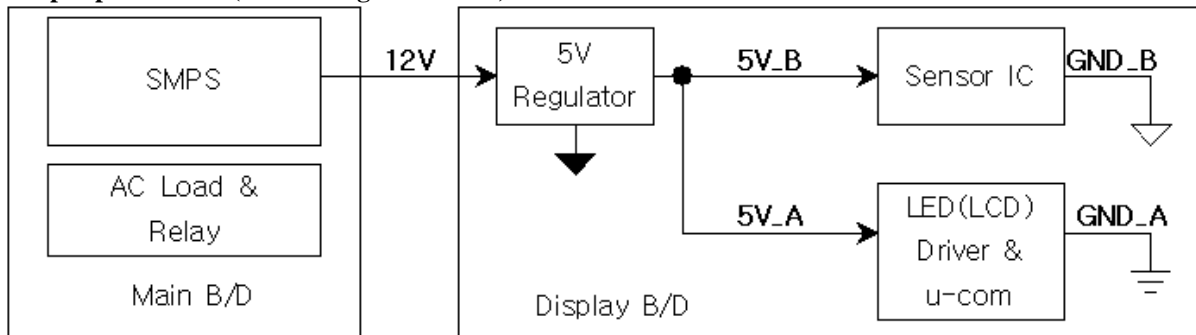
### 11.2 Example – Power Line Split Strategy PCB Layout

#### A. Not split power Line (Bad power line design)

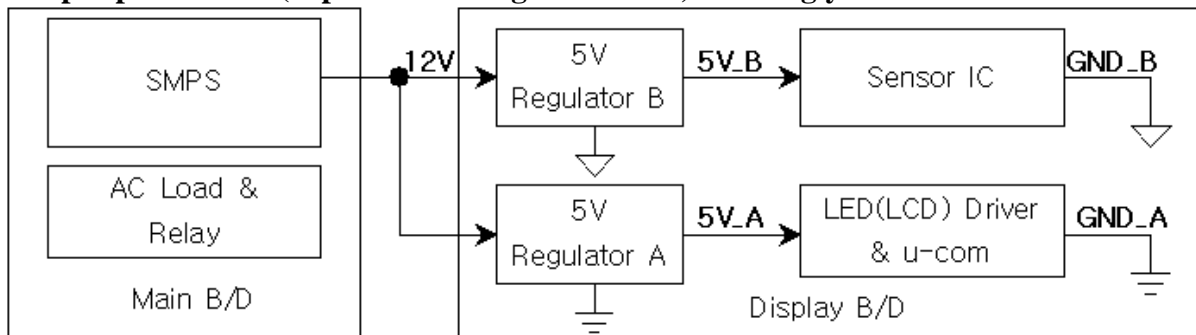


- ✓ The noise that is generated by AC load or relay can be loaded at 5V power line.
- ✓ A big inductance might be appeared in case of the connection line between main board and display board is too long, moreover the voltage ripple could be generated by LED (LCD) display driver at VDD (5V).

#### B. Split power Line (One 5V regulator used) – Recommended



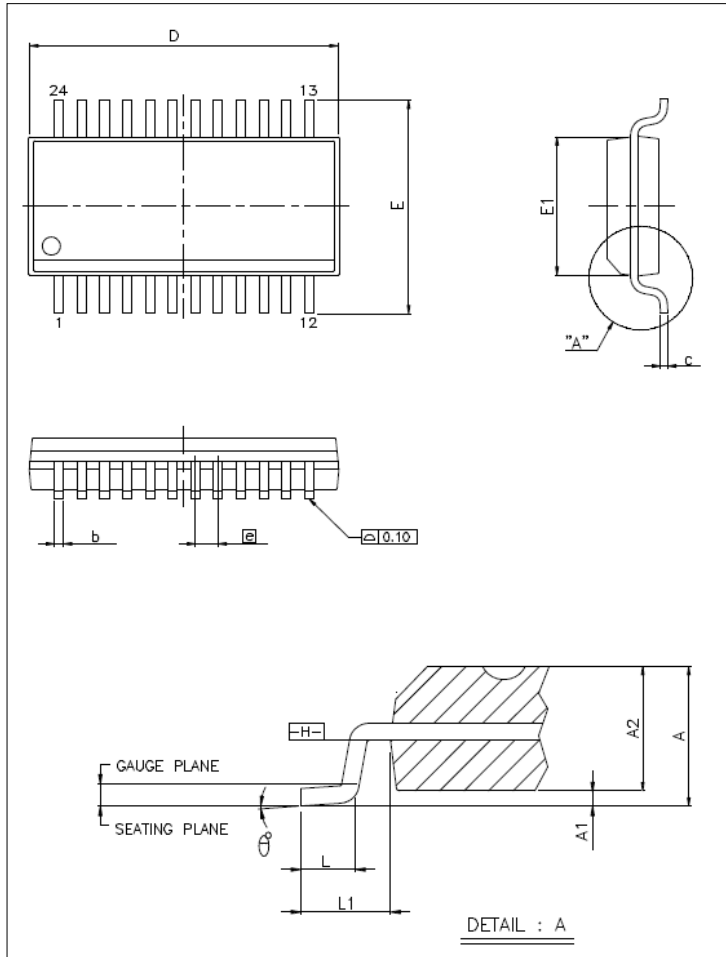
#### C. Split power Line (Separated 5V regulator used) – Strongly recommended



## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

### 12 MECHANICAL DRAWING

#### 12.1 Mechanical Drawing of ANMG08 (24 SSOP)



SYMBOLS	MIN.	NOM.	MAX.
A	1.35	1.63	1.75
A1	0.10	0.15	0.25
A2	—	—	1.50
D	8.56	8.66	8.74
E	5.79	5.99	6.20
E1	3.81	3.91	3.99
b	0.20	—	0.30
C	0.18	—	0.25
e	0.64 BASIC		
L	0.41	0.64	1.27
L1	1.04 BASIC		
θ°	0°	—	8°

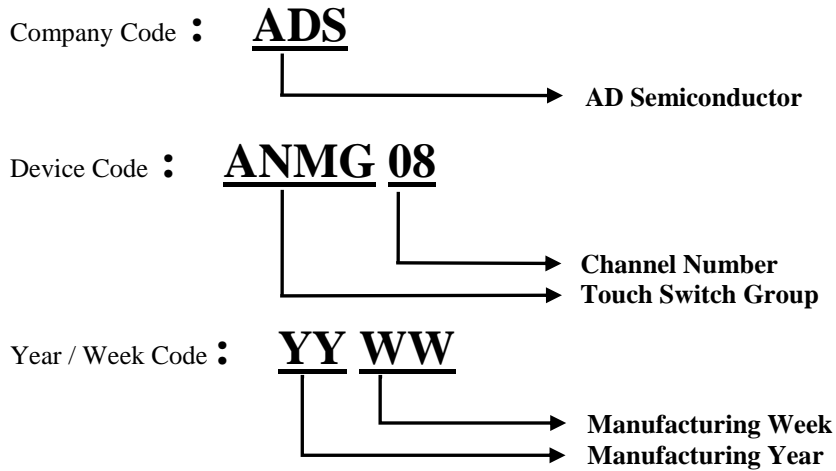
UNIT : MM

#### NOTES:

1. JEDEC OUTLINE : MO-137 AE
2. DIMENSION D DOES NOT INCLUDE MOLD PROTRUSIONS OR GATE BURRS. MOLD PROTRUSIONS AND GATE BURRS SHALL NOT EXCEED 0.15 MM PER SIDE. DIMENSION E1 DOES NOT INCLUDE INTERLEAD MOLD PROTRUSIONS. INTERLEAD MOLD PROTRUSIONS SHALL NOT EXCEED 0.25 MM PER SIDE.
3. DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION/INTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.10 MM TOTAL IN EXCESS OF b DIMENSION AT MAXIMUM MATERIAL CONDITION. DAMBAR INTRUSION SHALL NOT REDUCE DIMENSION b BY MORE THAN 0.05 MM AT LEAST.

### 13 MARKING DESCRIPTION

#### 13.1 Marking Description of ANMG08 (24 SSOP)



# ADSemiconductor®

" Free from Common Mode Noise "

---

## ANMG08 (8-CH Auto Sensitivity Calibration Capacitive Touch Sensor)

---

NOTES:

### LIFE SUPPORT POLICY

AD SEMICONDUCTOR'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT AND GENERAL COUNSEL OF AD SEMICONDUCTOR CORPORATION

The ADS logo is a registered trademark of ADSemiconductor

© 2006 ADSemiconductor – All Rights Reserved

[www.adsemicon.com](http://www.adsemicon.com)  
[www.adsemicon.co.kr](http://www.adsemicon.co.kr)